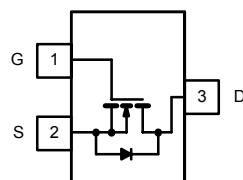


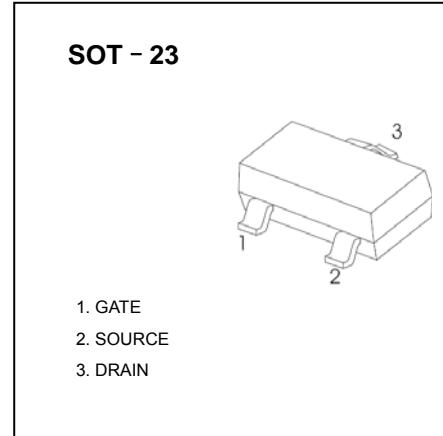
## N-Channel Enhancement MOSFET

## ■ Features

- $V_{DS}=20V$
- $R_{DS(on)}= 45m\Omega @ V_{GS}=4.5V, I_D=3.6A$
- $R_{DS(on)}= 60m\Omega @ V_{GS}=2.5V, I_D=3.1A$



SOT - 23

■ Absolute Maximum Ratings  $T_a = 25^\circ C$ 

Parameter		Symbol	Rating	Unit
Drain-Source Voltage	$T_a=25^\circ C$	$V_{DS}$	20	V
Gate-Source Voltage		$V_{GS}$	$\pm 8$	
Continuous Drain Current *1	$T_a=25^\circ C$	$I_D$	3.6	A
			3.1	
Pulsed Drain Current	$T_a=25^\circ C$	$I_{DM}$	10	W
Power Dissipation			1.25	
	$T_a=70^\circ C$		0.8	
Thermal Resistance.Junction- to-Ambient *1	$T_a=25^\circ C$	$R_{thJA}$	100	°C/W
			166	
Junction Temperature		$T_J$	150	°C
Storage Temperature Range			-55 to 150	

Notes:

\*1.Surface Mounted on FR4 Board,  $t \leq 5$  sec.

\*2.Surface Mounted on FR4 Board.

## N-Channel Enhancement MOSFET

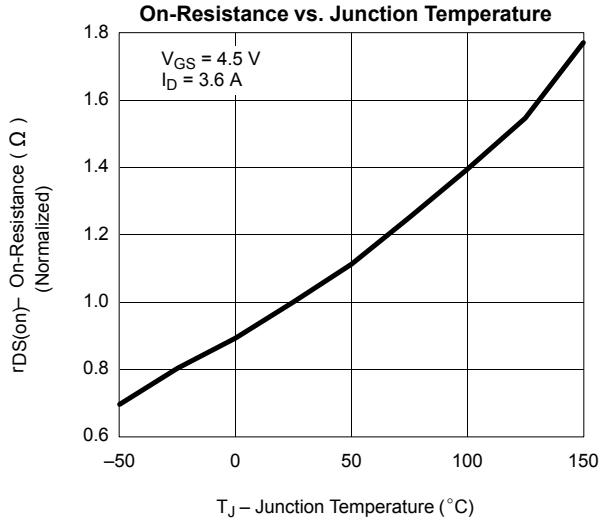
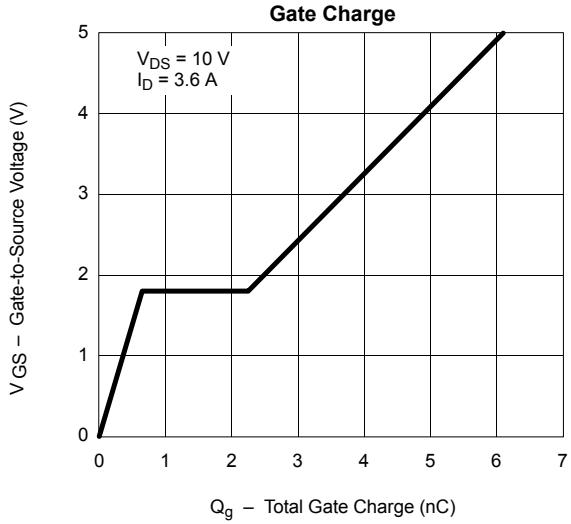
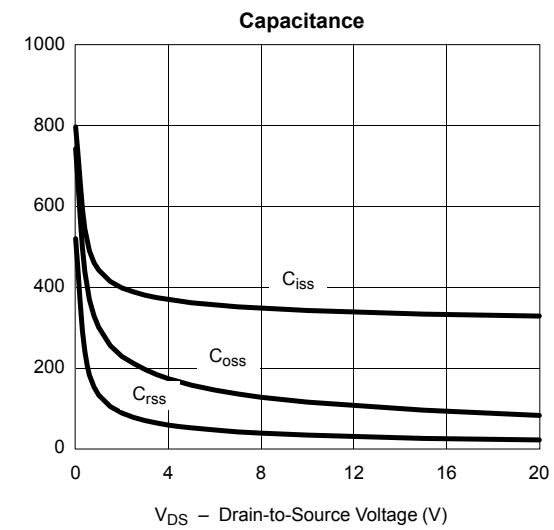
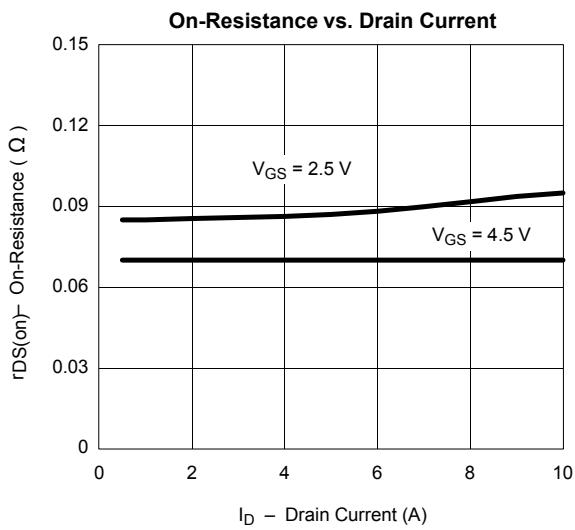
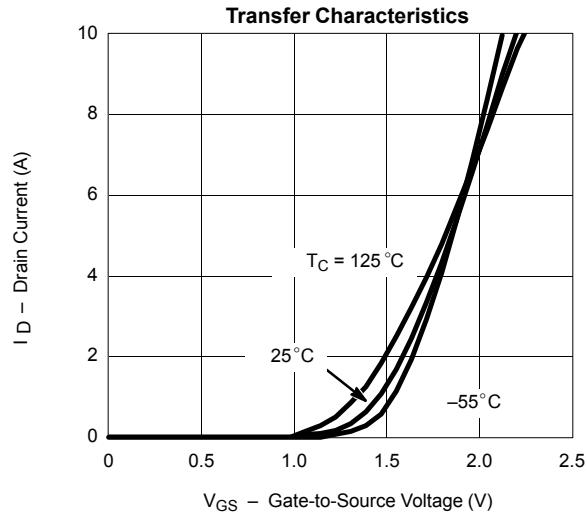
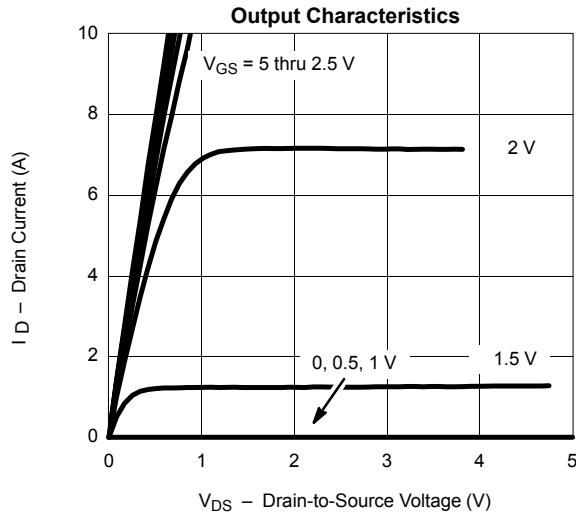
## ■ Electrical Characteristics Ta = 25°C

Parameter	Symbol	Test Conditions	Min	Typ	Max	Unit
Drain-Source Breakdown Voltage	V <sub>DSS</sub>	I <sub>D</sub> =250 μ A, V <sub>GS</sub> =0V	20			V
Zero Gate Voltage Drain Current	I <sub>DSS</sub>	V <sub>Ds</sub> =20V, V <sub>GS</sub> =0V			1	μ A
		V <sub>Ds</sub> =20V, V <sub>GS</sub> =0V, T <sub>J</sub> =55 °C			10	
Gate-Body Leakage Current	I <sub>GSS</sub>	V <sub>Ds</sub> =0V, V <sub>GS</sub> =±8V			± 100	nA
Gate Threshold Voltage	V <sub>GS(th)</sub>	V <sub>Ds</sub> =V <sub>GS</sub> , I <sub>D</sub> =250 μ A	0.62	0.95	1.9	V
Static Drain-Source On-Resistance	R <sub>Ds(on)</sub>	V <sub>GS</sub> =4.5V, I <sub>D</sub> =3.6A			45	mΩ
		V <sub>GS</sub> =2.5V, I <sub>D</sub> =3.1A			60	
Forward Transconductance *	g <sub>fs</sub>	V <sub>Ds</sub> =5V, I <sub>D</sub> =3.6A		8		S
Input Capacitance	C <sub>iss</sub>	V <sub>GS</sub> =0V, V <sub>Ds</sub> =10V, f=1MHz		300		pF
Output Capacitance	C <sub>oss</sub>			120		
Reverse Transfer Capacitance	C <sub>rss</sub>			80		
Total Gate Charge	Q <sub>g</sub>	V <sub>GS</sub> =10V, V <sub>GS</sub> =4.5V, I <sub>D</sub> =3.6A		4	10	nC
Gate-Source Charge	Q <sub>gs</sub>			0.65		
Gate-Drain Charge	Q <sub>gd</sub>			1.5		
Turn-On DelayTime	t <sub>d(on)</sub>	V <sub>GS</sub> =4.5V, V <sub>Ds</sub> =10V, R <sub>L</sub> =5.5 Ω, R <sub>GEN</sub> =6 Ω I <sub>D</sub> =3.6A		7	15	ns
Turn-On Rise Time	t <sub>r</sub>			55	80	
Turn-Off DelayTime	t <sub>d(off)</sub>			16	60	
Turn-Off Fall Time	t <sub>f</sub>			10	25	
Continuous Source Current (Diode Conduction)	I <sub>s</sub>			1.6		A
Diode Forward Voltage	V <sub>SD</sub>	I <sub>s</sub> =1.6A, V <sub>GS</sub> =0V		0.76	1.2	V

\* Pulse test: PW ≤300us duty cycle≤ 2%

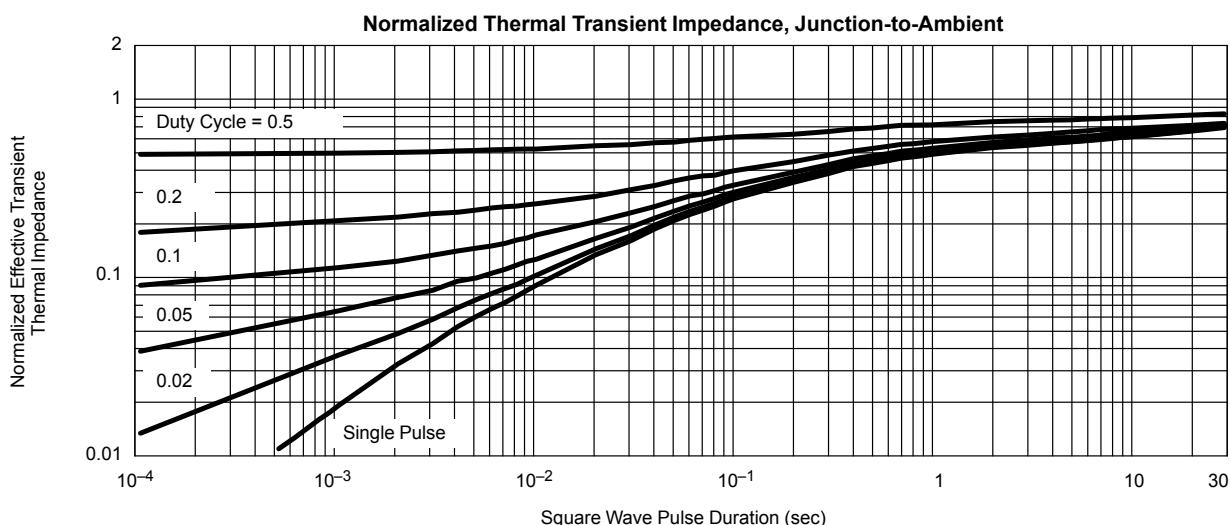
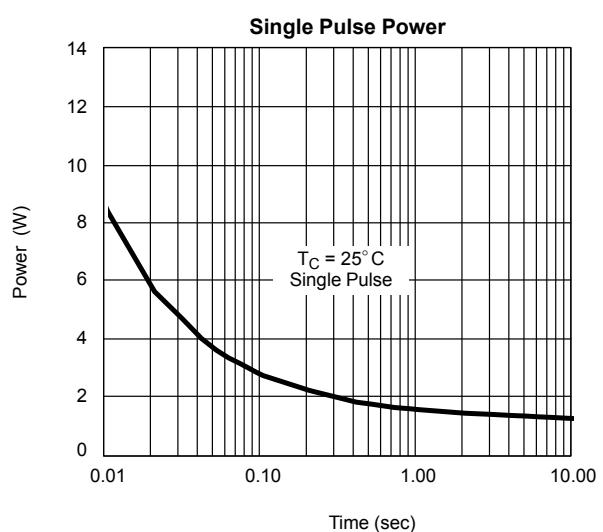
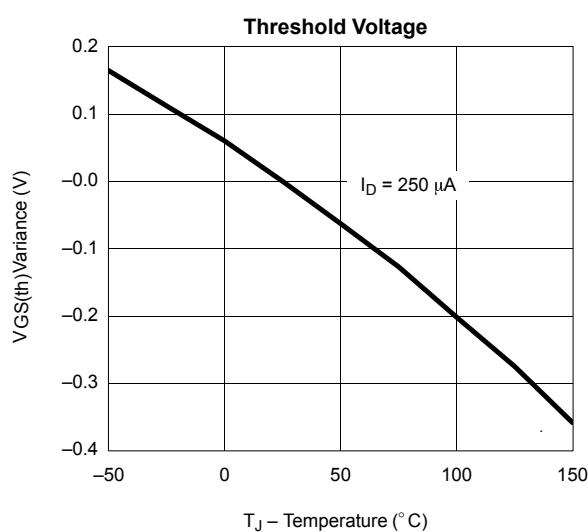
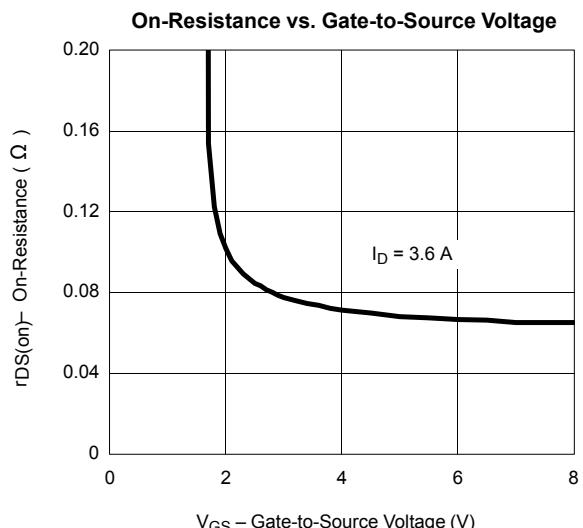
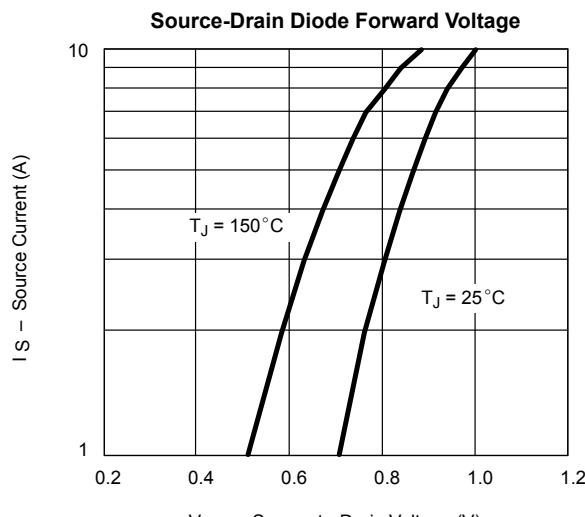
## N-Channel Enhancement MOSFET

## ■ Typical Characteristics



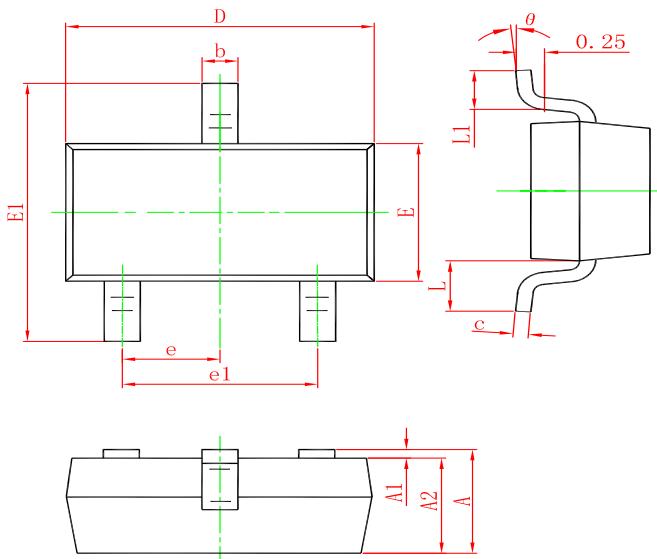
## N-Channel Enhancement MOSFET

## ■ Typical Characteristics



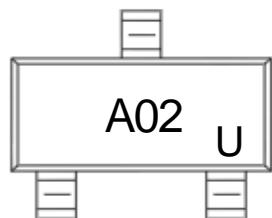
## N-Channel Enhancement MOSFET

## SOT-23 PACKAGE OUTLINE DIMENSIONS



Symbol	Dimensions In Millimeters		Dimensions In Inches	
	Min.	Max.	Min.	Max.
A	0.900	1.150	0.035	0.045
A1	0.000	0.100	0.000	0.004
A2	0.900	1.050	0.035	0.041
b	0.300	0.500	0.012	0.020
c	0.080	0.150	0.003	0.006
D	2.800	3.000	0.110	0.118
E	1.200	1.400	0.047	0.055
E1	2.250	2.550	0.089	0.100
e	0.950 TYP.		0.037 TYP.	
e1	1.800	2.000	0.071	0.079
L	0.550 REF.		0.022 REF.	
L1	0.300	0.500	0.012	0.020
θ	0°	8°	0°	8°

## Marking



## Ordering information

Order code	Package	Baseqty	Deliverymode
SI2302A	SOT-23	3000	Tape and reel